

MLP252012S Series

FEATURES

- Use magnetic materials with high saturation magnetic flux density to achieve good DC superposition characteristics in power circuits.
- Achieve universality and stability of pad layout with SMD product shape and terminal structure.
- Use closed magnetic circuit structure to control the minimum magnetic flux loss.
- RoHS compliant.
- Operating temperature -40~+125 (Including self -temperature rise)

APPLICATIONS

• smart phones, tablets, SSD, DVC, DSC, VC, wristbands, watches, power modules, etc.

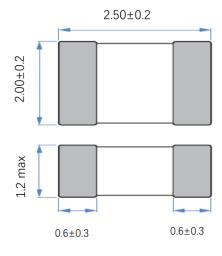
Explanation of Part Number

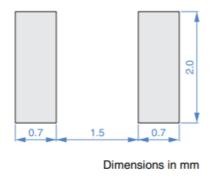
MLP 252012 S 1R0 M T

1 2 3 4 5 6

- ♠ 2:Dimensions:
- ♦ 3: Series Code
- ♦ 4: Initial inductance value: 1R0 = 1.0uH
- ♦ 5:Tolerance of Inductance:M:±20%
- ♦ 6:Packing:Tape Carrier Package

Dimensions: [mm]







Electrical Properties:

Part No.	L (uH)	Tolerance	Measuring Frequency	DCR(mΩ)		*Isat(A)		*Itemp(A)	
			(MHz)	typ	max	typ	max	typ	max
MLP252012S1R0MT	1.0	±20%	1	37	44	4.9	4.5	4.3	4.0
MLP252012S1R5MT	1.5	±20%	1	51	62	4.0	3.6	3.3	2.9
MLP252012S2R2MT	2.2	±20%	1	96	110	2.8	2.6	2.6	2.4

Notes:

1. Test Condition:1MHz, 1.0Vrms, referenced to 25 °C ambient.

2. Rated Current: Isat or Itemp, whichever is smaller.

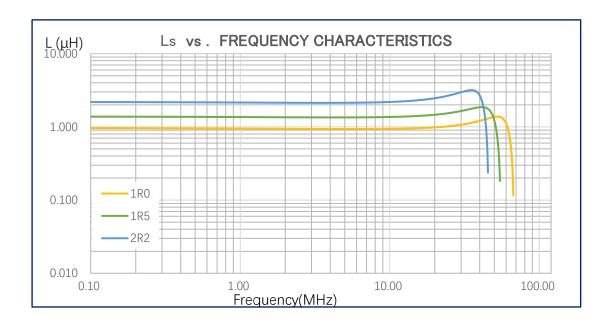
Isat: the current (A) that will cause the L value to drop 30%.

Itemp: the current (A) that will cause a temperature rise of 40°C.

Please feel free to contact us for further information on rated current and product temperature characteristics.

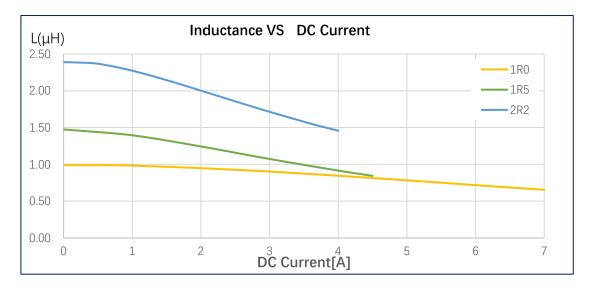
3. Maximum rated voltage :DC 20 V

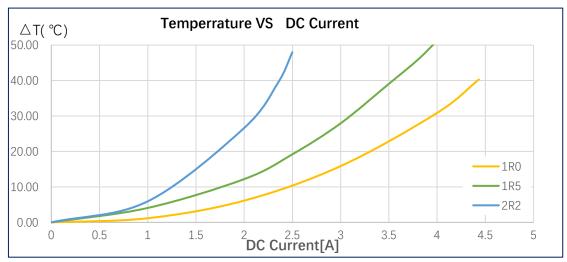
L Frequency Characteristics





Inductor DC Superposition Characteristics







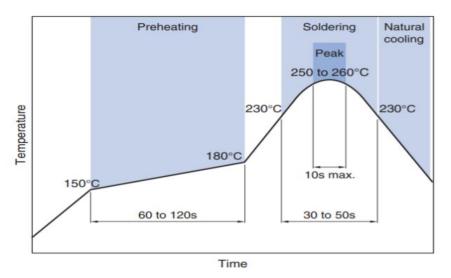
Reliability test

No.	project	Expe	rimental standard	Judgment conditions		
1	Solder attachment experiment		ed in tin 245°C±5°C	More than 95% of the surface must be covered by tin without detachment No abnormal appearance		
2	Mechanical vibration experiment	Vibra	ne product to be ve tion frequency: 10H eration or amplitud 36	No abnormal appearance No open circuit or short circuit occurred. △L/L ≤ 10%,		
3	Mechanical shock experiment	Maxir Sine I	ne product to be ve mum acceleration 9 nalf-wave pulse with 3 times in each of th	No abnormal appearance No open circuit or short circuit occurred. $\mid \triangle \text{L/L} \mid \leq 10\%,$		
4	High temperature operation	500hr	d at 85±2°C r±12hr through rate d in room temperat	No abnormal appearance No open circuit or short circuit occurred. $\mid \triangle \text{L/L} \mid \leq 10\%,$		
5	Thermal shock experiment		ollowing table is for ured after placing	No abnormal appearance No open circuit or short circuit occurred. $ \triangle L/L \leq 10\%,$		
			Temperature	Time		
		1	-40±3°C	30 min.		
		2	room temperature	Within 1min		
		3	125±2°C	30 min.		
		4	room temperature	Within 1min		
6	High temperature storage	125±2°C under the condition of room humidity 500hr±12hr Placed in room temperature and humidity for 1h before testing No abnormal appearance No open circuit or sho circuit occurred. $ \triangle L/L \le 10\%$,				
7	Low temperature storage	500h:	d at -40±2°C ±12h d in room temperat	No abnormal appearance No open circuit or short circuit occurred. △L/L ≤ 10%,		

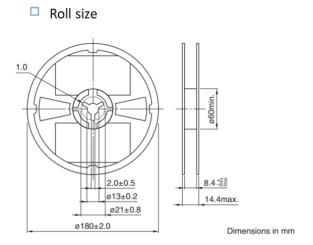
8	High	85±2°C 85%RH	No abnormal appearance				
	temperature	500hr±12hr	No open circuit or short				
	and high	Placed in room temperature and humidity for 1hr before testing	circuit occurred.				
	humidity		△L/L ≦ 10%,				
	storage						
9	Substrate	Put the sample on the substrate to solder, apply pressure in the	No abnormal appearance				
	bending	direction of the arrow until the amount of bending becomes about	No open circuit or short				
		3mm, hold for 30 seconds	circuit occurred.				
		10 R340 R340 R5±2 R5	△L/L ≦ 10%,				
10	Electrode	Apply 0.5mm/sec on the side of the sample using a specified	> 10N				
	strength	pressure jig (see Figure 1).					
		The tip of the fixture that is in contact with					
		the sample should be centered on the					
		sample surface. Apply a force parallel to					
		the substrate (shear force) to observe the					
		adhesion of the glass epoxy substrate to					
		the product.					
11	Reflow	Substrate reflow 3 times	No abnormal appearance				
	soldering test	°C Peak temperature	No open circuit or short				
		Pre-heating 260±3°C, 10sec max	circuit occurred.				
		230	$ \triangle L/L \leq 10\%,$				
		150 Slow cooling					
		3~5°C/sec					
		120sec 30sec Soaking temperature					

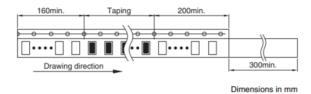


Recommended Reflow Soldering Temperature Profile

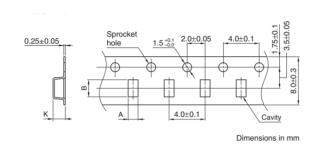


Package Style





Tape size



Туре	A0	В0	K	t
MLP252012	2.39±0.1	3.0±0.1	1.25±0.1	0.22±0.05

■Packing Quantity

Packing Quantity	3000 pcs/ roll



Safety Precautions

When using this product, please pay attention to safety matters.

∧ Notice

OThe storage period is less than 12 months. Be sure to follow the storage conditions (temperature: 5 ~ 40°C; humidity 20 ~ 75%RH or less).

If the storage period elapses, the soldering of the terminal electrodes may deteriorate.

ODo not use and store in gas corrosive environments (salt, acid, alkali, etc.).

OBefore soldering, be sure to preheat components.

The preheating temperature should be set so that the difference between soldering temperature and chip temperature does not exceed 150°C.

OSoldering corrections after mounting should be within the conditions determined in the specification.

Excessive heating may result in short circuit, performance degradation, or shortened lifespan.

OWhen embedding a printed circuit board where a chip is mounted to a set, be sure that residual stress is not given to the chip due to the overall distortion of the printed circuit board and partial distortion such as at screw tightening portions.

OSelf-heating (temperature increase) occurs when the power is turned ON, so the tolerance should be sufficient for the set thermal design.

OCarefully lay out the coil for the circuit board design of the non-magnetic shield type. A malfunction may occur due to magnetic interference.

OUse a wrist band to discharge static electricity in your body through the grounding wire.

ODo not expose the products to magnets or magnetic fields.

ODo not use for a purpose outside of the range specified in the product specification.

OThe products listed in this catalog are intended for use in general electronic equipment (AV equipment, telecommunication equipment, home appliances, entertainment equipment, computer equipment, personal equipment, office equipment, measuring equipment, industrial robots), and under a normal operation and use condition. The products are not designed or warranted to meet the requirements of the applications listed below, of which the performance and/or quality require a more stringent level of safety or reliability, or of which the failure, malfunction or trouble could cause serious damage to society, person or property.

If you intend to use the products in the applications or if you have special requirements exceeding the range or conditions set forth in the catalog, please contact us.

- (1) Aviation and aerospace equipment
- (2) Transportation equipment (cars, trains, ships, etc.)
- (3) Medical equipment
- (4) Power-generation control equipment
- (5) Atomic energy-related equipment
- (6) Submarine equipment
- (7) Vehicle control equipment
- (8) Highly public information processing equipment
- (9) Military equipment
- (10) Electric heating supplies, combustion equipment
- (11) Disaster prevention and anti-theft equipment
- (12) Safety equipment
- (13) Other applications that are not considered general-purpose applications

When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration the protective circuit/device or providing backup circuits in your equipment.